

MOS FIELD EFFECT TRANSISTOR NP36P06SLG

SWITCHING P-CHANNEL POWER MOSFET

DESCRIPTION

The NP36P06SLG is P-channel MOS Field Effect Transistor designed for high current switching applications.

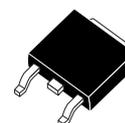
FEATURES

- Super low on-state resistance
 $R_{DS(on)1} = 30 \text{ m}\Omega \text{ MAX. (} V_{GS} = -10 \text{ V, } I_D = -18 \text{ A)}$
 $R_{DS(on)2} = 40 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.5 \text{ V, } I_D = -18 \text{ A)}$
- Low input capacitance
 $C_{iss} = 3200 \text{ pF TYP.}$
- Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
NP36P06SLG	TO-252 (MP-3ZK)

(TO-252)



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C)

Drain to Source Voltage (V _{GS} = 0 V)	V _{DSS}	-60	V
Gate to Source Voltage (V _{DS} = 0 V)	V _{GSS}	±20	V
Drain Current (DC) (T _C = 25°C)	I _{D(DC)}	±36	A
Drain Current (pulse) ^{Note1}	I _{D(pulse)}	±108	A
Total Power Dissipation (T _C = 25°C)	P _{T1}	56	W
Total Power Dissipation (T _A = 25°C)	P _{T2}	1.2	W
Channel Temperature	T _{ch}	175	°C
Storage Temperature	T _{stg}	-55 to +175	°C
Single Avalanche Current ^{Note2}	I _{AS}	23.4	A
Single Avalanche Energy ^{Note2}	E _{AS}	54.8	mJ

Notes 1. PW ≤ 10 μs, Duty Cycle ≤ 1%

2. Starting T_{ch} = 25°C, V_{DD} = -30 V, R_G = 25 Ω, V_{GS} = -20 → 0 V

THERMAL RESISTANCE

Channel to Case Thermal Resistance	R _{th(ch-C)}	2.68	°C/W
Channel to Ambient Thermal Resistance	R _{th(ch-A)}	125	°C/W

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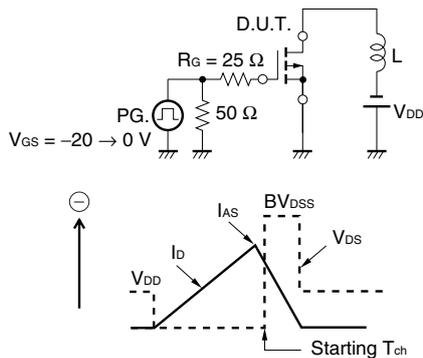
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ELECTRICAL CHARACTERISTICS (T_A = 25°C)

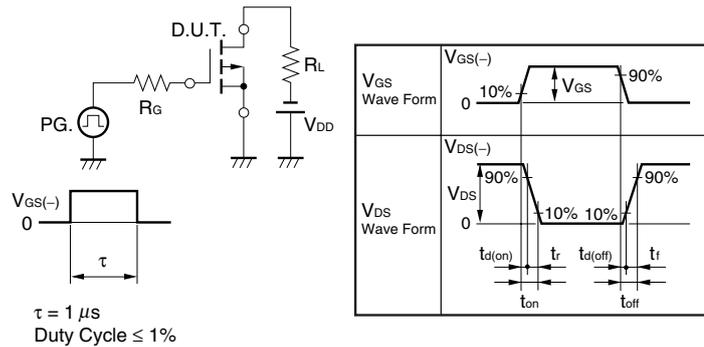
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V			-10	μA
Gate Leakage Current	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.0	-2.0	-2.5	V
Forward Transfer Admittance ^{Note}	y _{fs}	V _{DS} = -10 V, I _D = -18 A	12			S
Drain to Source On-state Resistance ^{Note}	R _{DS(on)1}	V _{GS} = -10 V, I _D = -18 A		24	30	mΩ
	R _{DS(on)2}	V _{GS} = -4.5 V, I _D = -18 A		27	40	mΩ
Input Capacitance	C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V,		3200		pF
Output Capacitance	C _{oss}	f = 1 MHz		350		pF
Reverse Transfer Capacitance	C _{rss}			205		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = -30 V, I _D = -18 A,		7		ns
Rise Time	t _r	V _{GS} = -10 V,		12		ns
Turn-off Delay Time	t _{d(off)}	R _G = 0 Ω		190		ns
Fall Time	t _f			110		ns
Total Gate Charge	Q _G	V _{DD} = -48 V,		52		nC
Gate to Source Charge	Q _{GS}	V _{GS} = -10 V,		6.9		nC
Gate to Drain Charge	Q _{GD}	I _D = -36 A		15		nC
Body Diode Forward Voltage ^{Note}	V _{F(S-D)}	I _F = -36 A, V _{GS} = 0 V			1.2	V
Reverse Recovery Time	t _{rr}	I _F = -36 A, V _{GS} = 0 V,		46		ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100 A/μs		75		nC

Note Pulsed test PW ≤ 350 μs, Duty Cycle ≤ 2%

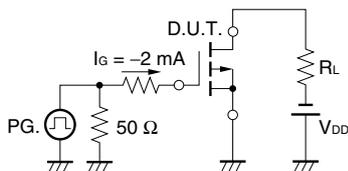
TEST CIRCUIT 1 AVALANCHE CAPABILITY



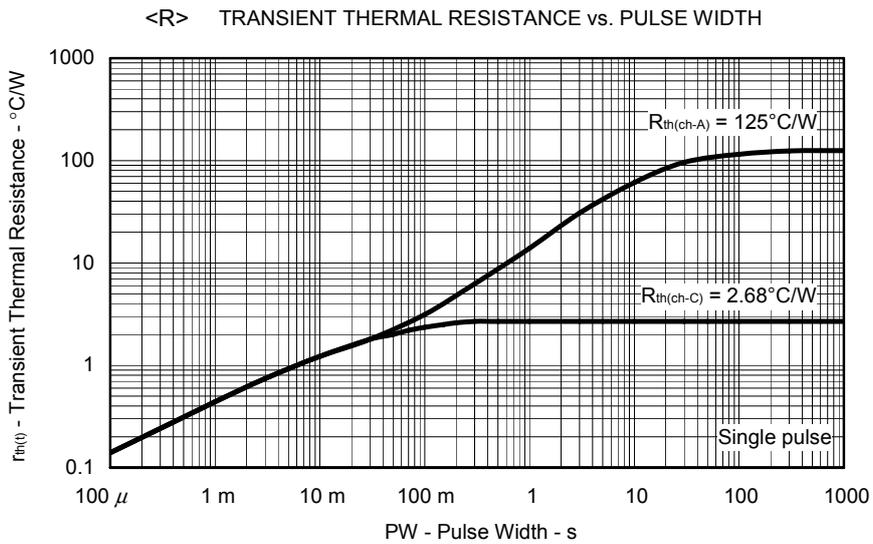
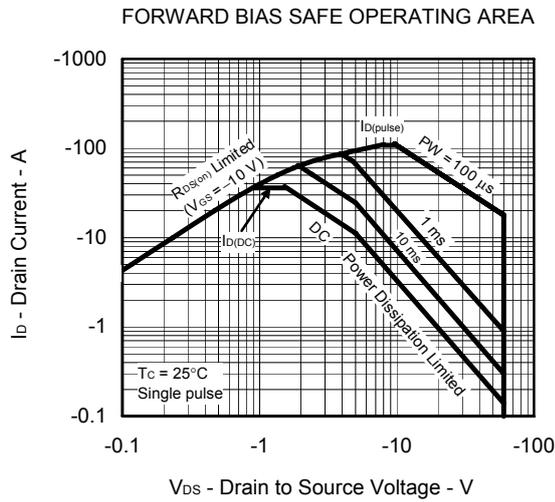
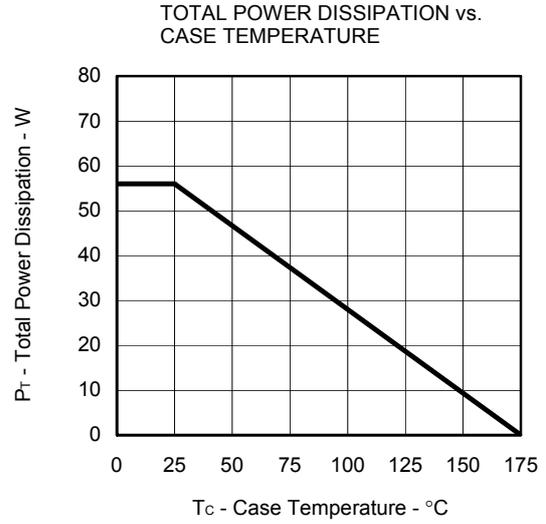
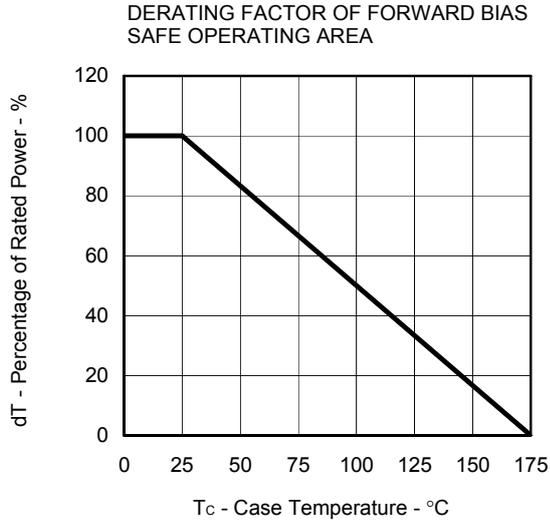
TEST CIRCUIT 2 SWITCHING TIME



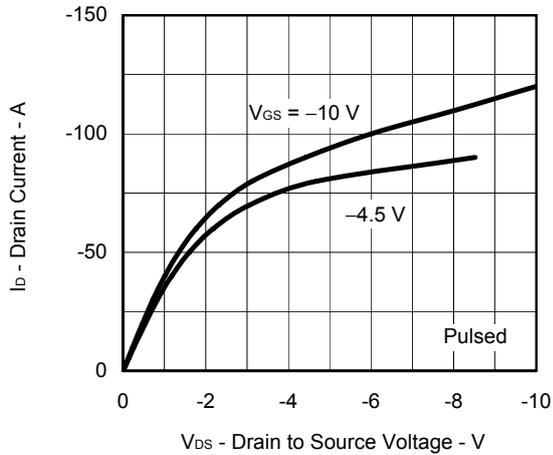
TEST CIRCUIT 3 GATE CHARGE



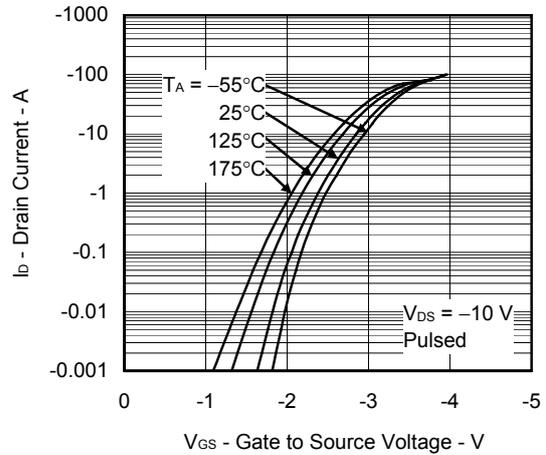
TYPICAL CHARACTERISTICS (T_A = 25°C)



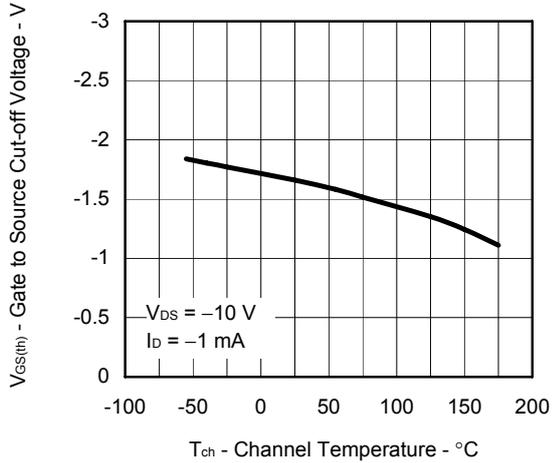
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



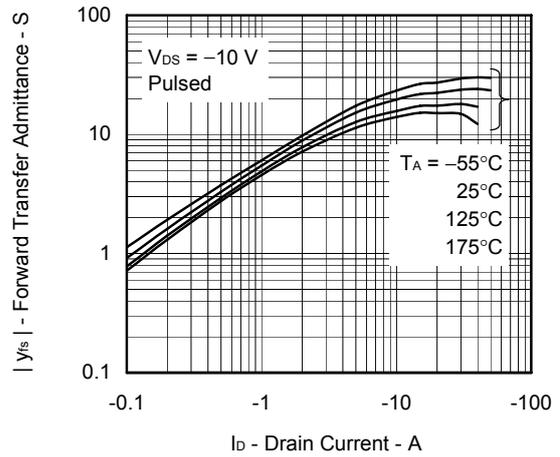
FORWARD TRANSFER CHARACTERISTICS



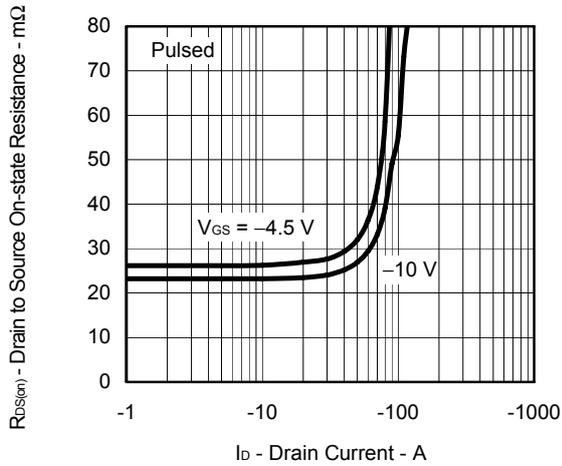
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



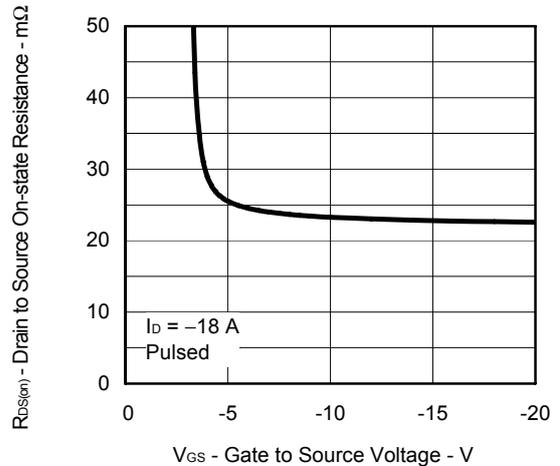
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



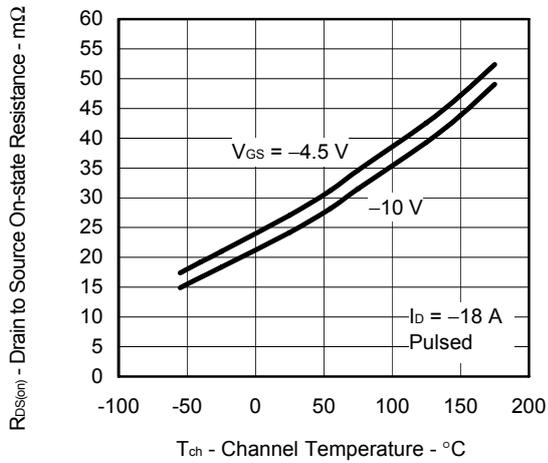
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



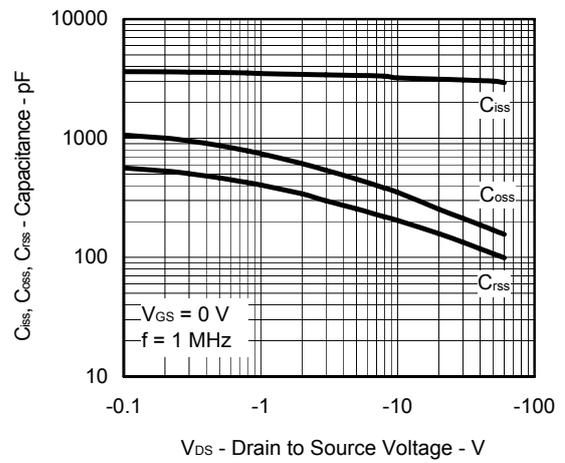
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



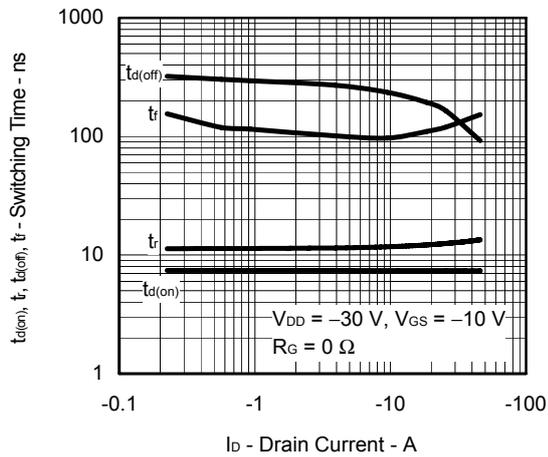
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



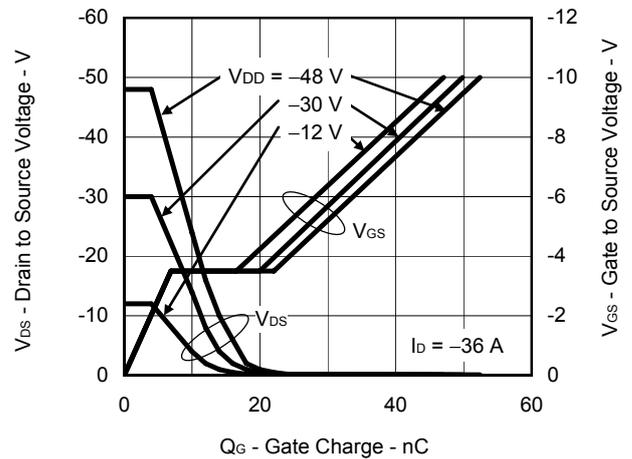
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



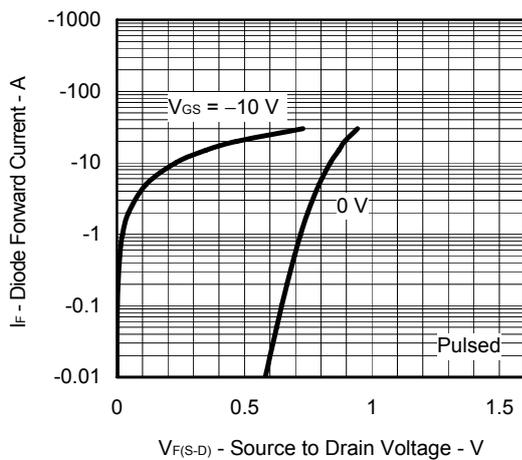
SWITCHING CHARACTERISTICS



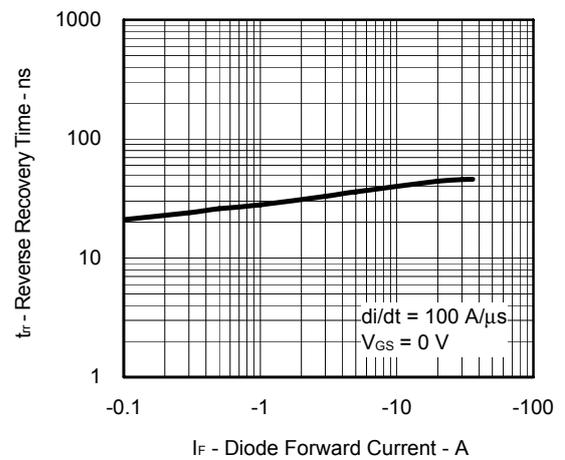
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



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